FQD12P10TM_F085 P-Channel MOSFET FAIRCHILD SEMICONDUCTOR February 2010 FQD12P10TM F085 100V P-Channel MOSFET **General Description** Features These P-Channel enhancement mode power field effect • -9.4A, -100V, $R_{DS(on)} = 0.29\Omega @V_{GS} = -10 V$ transistors are produced using Fairchild's proprietary, Low gate charge (`typical 21 nC) planar stripe, DMOS technology. Low Crss (typical 65 pF) This advanced technology has been especially tailored to Fast switching minimize on-state resistance, provide superior switching 100% avalanche tested performance, and withstand high energy pulse in the Improved dv/dt capability avalanche and commutation mode. These devices are well Qualified to AEC Q101 suited for low voltage applications such as audio amplifier, **RoHS** Compliant high efficiency switching DC/DC converters, and DC motor control. D D D-PAK Absolute Maximum Ratings $T_{C} = 25^{\circ}C$ unless otherwise noted Symbol Parameter Ratings Units V_{DSS} **Drain-Source Voltage** -100 V - Continuous (T_C = 25°C) Drain Current -9.4 А I_D - Continuous (T_C = 100°C) -6.0 А Drain Current - Pulsed -37.6 А IDM (Note 1) V_{GSS} Gate-Source Voltage ± 30 v E_{AS} Single Pulsed Avalanche Energy (Note 2) 370 mJ -9.4 Avalanche Current IAR (Note 1) А E_{AR} Repetitive Avalanche Energy 5.0 (Note 1) mJ dv/dt Peak Diode Recovery dv/dt (Note 3) -6.0 V/ns Power Dissipation ($T_A = 25^{\circ}C$) 2.5 W P_D

* When mounted on the minimum pad size recommended (PCB Mount)

Power Dissipation ($T_C = 25^{\circ}C$)

1/8" from case for 5 seconds

- Derate above 25°C

Parameter

1

Maximum lead temperature for soldering purposes,

Operating and Storage Temperature Range

Thermal Resistance, Junction-to-Case

Thermal Resistance, Junction-to-Ambient *

Thermal Resistance, Junction-to-Ambient

Thermal Characteristics

T_J, T_{STG}

Symbol

 $R_{\theta JC}$

 $R_{\theta JA}$

 $R_{\theta JA}$

T_L

W

W/°C

°C

°C

Units

°C/W

°C/W

°C/W

50

0.4

-55 to +150

300

Тур

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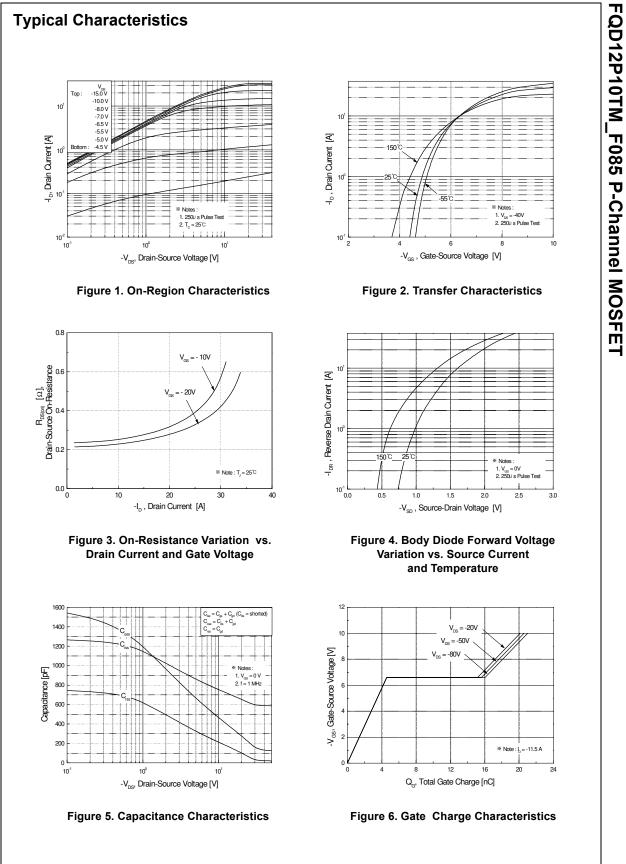
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2.5

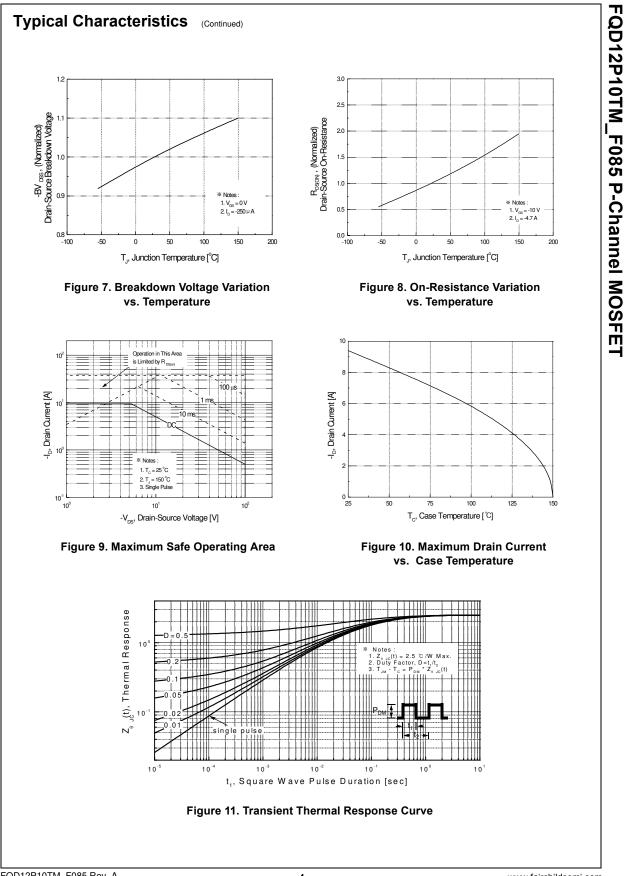
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110

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|------------------------------------|--|--|------|-------------|-------|----------|
| Off Cha | racteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} = 0 V, I _D = -250 μA | -100 | | | V |
| ABV _{DSS} | Breakdown Voltage Temperature | | | | | v |
| $\Delta T_{\rm J}$ | Coefficient | $I_D = -250 \ \mu$ A, Referenced to 25° | 0 | -0.1 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | -1 | μA |
| | | $V_{DS} = -80 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$ | | | -10 | μA |
| GSSF | Gate-Body Leakage Current, Forward | $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| GSSR | Gate-Body Leakage Current, Reverse | $V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| On Cha | racteristics | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} , I _D = -250 μA | -2.0 | | -4.0 | V |
| R _{DS(on)} | Static Drain-Source | | 2.0 | | | v |
| .DS(on) | On-Resistance | $V_{GS} = -10 \text{ V}, \text{ I}_{D} = -4.7 \text{ A}$ | | 0.24 | 0.29 | Ω |
| 9FS | Forward Transconductance | $V_{DS} = -40 \text{ V}, \text{ I}_{D} = -4.7 \text{ A}$ (Note 4 |) | 6.3 | | S |
| | | 1 | | | | |
| - | ic Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ | | 620 | 800 | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 220 | 290 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 65 | 85 | pF |
| Switchi | ng Characteristics | | | | | |
| d(on) | Turn-On Delay Time | V _{DD} = -50 V, I _D = -11.5 A, | | 15 | 40 | ns |
| r | Turn-On Rise Time | $R_{G} = 25 \Omega$ | | 160 | 330 | ns |
| d(off) | Turn-Off Delay Time | | | 35 | 80 | ns |
| f | Turn-Off Fall Time | (Note 4, | 5) | 60 | 130 | ns |
| Qg | Total Gate Charge | V _{DS} = -80 V, I _D = -11.5 A, | | 21 | 27 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = -10 V | | 4.6 | | nC |
| ე _{gd} | Gate-Drain Charge | (Note 4, | 5) | 11.5 | | nC |
| | | | | | | |
| | ource Diode Characteristics an | • | | | 0.4 | • |
| S | | iximum Continuous Drain-Source Diode Forward Current | | | -9.4 | A |
| SM | Maximum Pulsed Drain-Source Diode F | | | | -37.6 | A |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 V, I_S = -9.4 A$ | | | -4.0 | V |
| | | $V_{GS} = 0 V, I_S = -11.5 A,$ dI_ / dt = 100 A/us (Note 4) | \ | | | |
| ×rr | neverse necovery charge | | | 0.47 | | μΟ |
| | Reverse Recovery Time Reverse Recovery Charge ating : Pulse width limited by maximum junction temper $A_S = -9.4A$, $V_{DD} = -25V$, $R_G = 25 \Omega$. Starting $T_J = 25^{\circ}C$ | $dI_F / dt = 100 \text{ A}/\mu \text{s}$ (Note 4 rature |) | 110 0.47 | | ns μC |
| $I_{SD} \le -11.5$ Pulse Test : | Å, di/dt ≤ 300Å/µs, V _{DD} ≤ BV _{DSS} , Starting T _J = 25°C Pulse width ≤ 300µs, Duty cycle ≤ 2% independent of operating temperature | | | | | |
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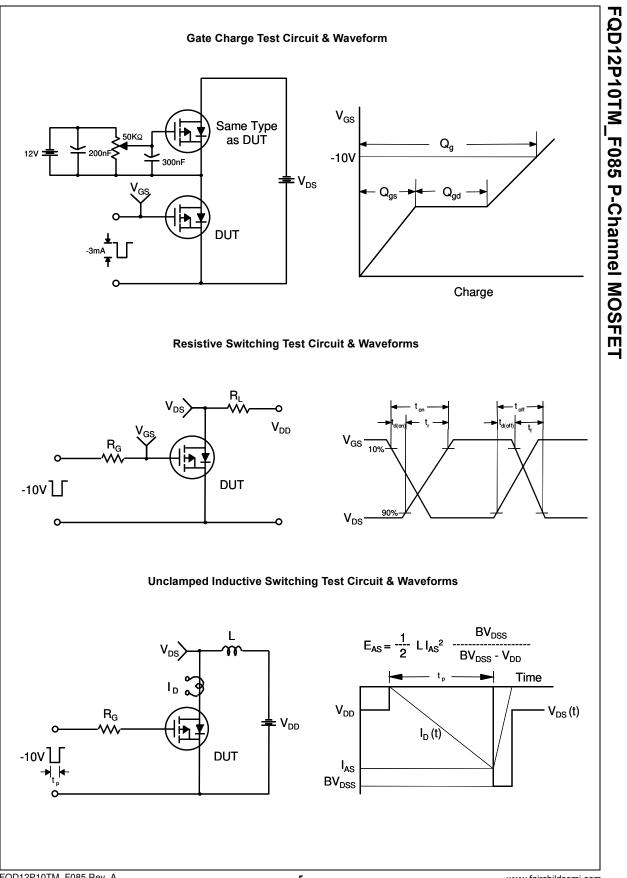


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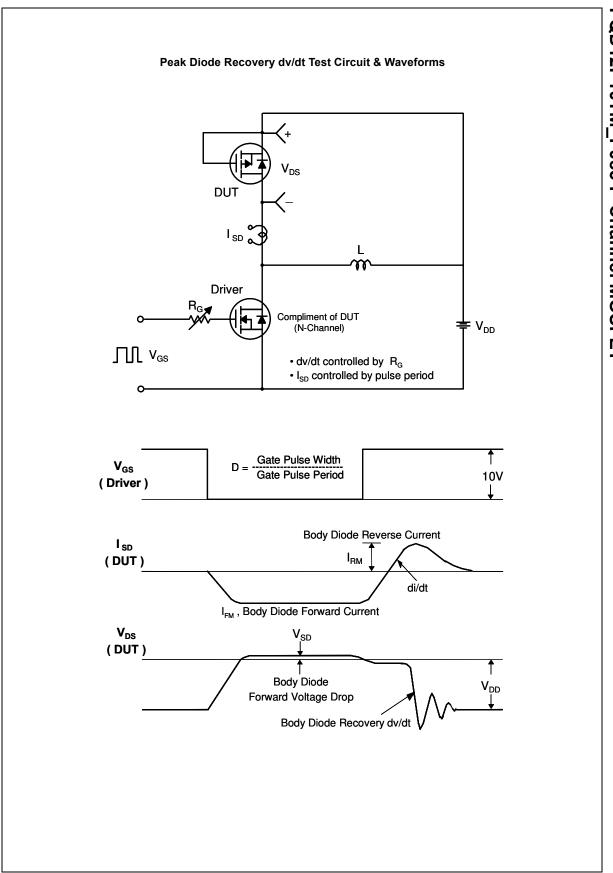


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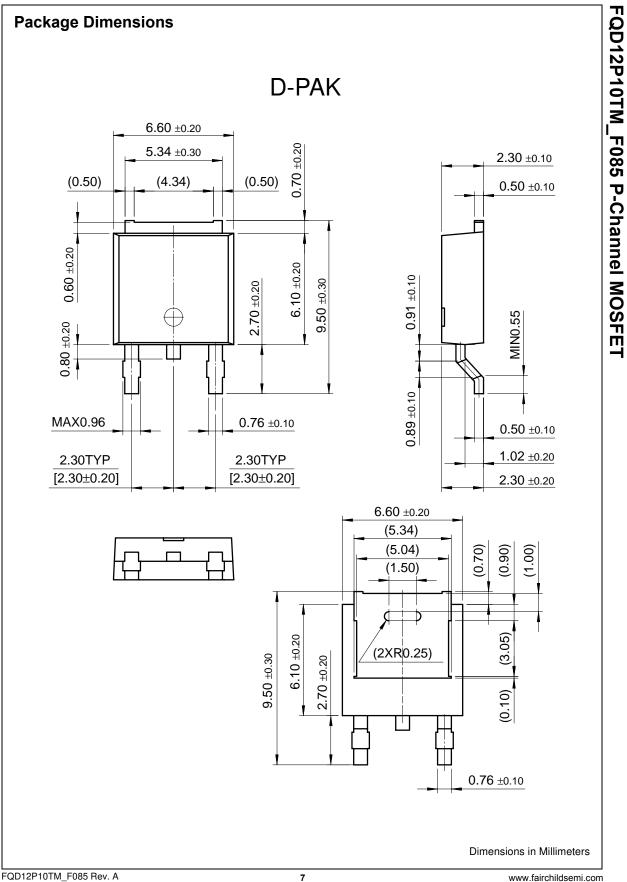
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